

<b>Notice of References Cited</b>	Application/Control No. 10/642,521	Applicant(s)/Patent Under Reexamination SHIMURA ET AL.	
	Examiner Hoan H. Tran	Art Unit 2852	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,505,012	01-2003	Maebashi et al.	399/49
	B	US-6,477,338	11-2002	Hisano et al.	399/49
	C	US-6,181,888	01-2001	Scheuer et al.	399/49
	D	US-6,029,021	02-2000	Nishimura et al.	399/49
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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